

- Nominal Frequency

44.237MHz

L Pin 1 Connection

Duty Cycle 50 ±5(%)

Tri-State (High Impedance)

EH25 00 ET T TS -44.237M

RoHS Compliant (Pb-free) 5.0V 4 Pad 5mm x 7mm Ceramic SMD HCMOS/TTL High Frequency Oscillator

Frequency Tolerance/Stability ±100ppm Maximum

Operating Temperature Range --40°C to +85°C

### **ELECTRICAL SPECIFICATIONS**

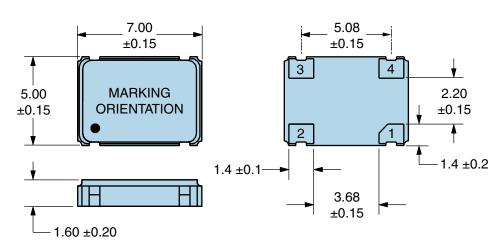
Series -

| Nominal Frequency                     | 44.237MHz   |  |
|---------------------------------------|---|--|
| Frequency Tolerance/Stability         | ±100ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the<br>Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C,<br>Shock, and Vibration) |  |
| Aging at 25°C                         | ±5ppm/year Maximum  |  |
| Operating Temperature Range           | -40°C to +85°C  |  |
| Supply Voltage                        | 5.0Vdc ±10%   |  |
| Input Current                         | 50mA Maximum (No Load)  |  |
| Output Voltage Logic High (Voh)       | 2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)   |  |
| Output Voltage Logic Low (Vol)        | 0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOH= +16mA)   |  |
| Rise/Fall Time                        | 6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  |  |
| Duty Cycle                            | 50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)   |  |
| Load Drive Capability                 | 10TTL Load or 50pF HCMOS Load Maximum   |  |
| Output Logic Type                     | CMOS  |  |
| Pin 1 Connection                      | Tri-State (High Impedance)  |  |
| Tri-State Input Voltage (Vih and Vil) | +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  |  |
| Absolute Clock Jitter                 | ±250pSec Maximum, ±100pSec Typical  |  |
| One Sigma Clock Period Jitter         | ±50pSec Maximum, ±30pSec Typical  |  |
| Start Up Time                         | 10mSec Maximum  |  |
| Storage Temperature Range             | -55°C to +125°C   |  |
|                                       |   |  |

### **ENVIRONMENTAL & MECHANICAL SPECIFICATIONS**

| ESD Susceptibility           | MIL-STD-883, Method 3015, Class 1, HBM: 1500V |
|------------------------------|---|
| Fine Leak Test               | MIL-STD-883, Method 1014, Condition A         |
| Flammability                 | UL94-V0                                       |
| Gross Leak Test              | MIL-STD-883, Method 1014, Condition C         |
| Mechanical Shock             | MIL-STD-883, Method 2002, Condition B         |
| Moisture Resistance          | MIL-STD-883, Method 1004                      |
| Moisture Sensitivity         | J-STD-020, MSL 1                              |
| Resistance to Soldering Heat | MIL-STD-202, Method 210, Condition K          |
| Resistance to Solvents       | MIL-STD-202, Method 215                       |
| Solderability                | MIL-STD-883, Method 2003                      |
| Temperature Cycling          | MIL-STD-883, Method 1010, Condition B         |
| Vibration                    | MIL-STD-883, Method 2007, Condition A         |

### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



| PIN  | CONNECTION     |
|------|----------------|
| 1    | Tri-State      |
| 2    | Ground         |
| 3    | Output         |
| 4    | Supply Voltage |
| LINE | MARKING        |
| 1    | ECLIPTEK       |
| 2    | 44.237M        |
| 3    | XXXXXX         |

#### Suggested Solder Pad Layout

All Dimensions in Millimeters

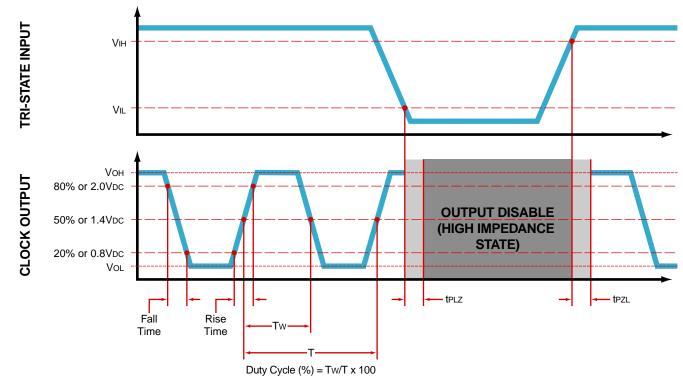


All Tolerances are ±0.1



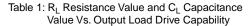


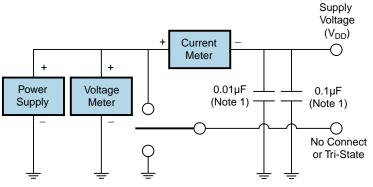
#### **OUTPUT WAVEFORM & TIMING DIAGRAM**

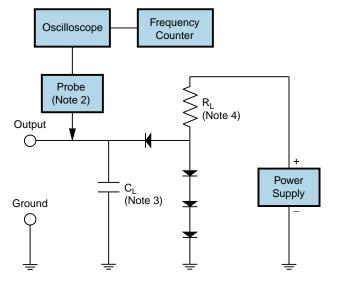


#### Test Circuit for TTL Output

| Output Load<br>Drive Capability | R <sub>L</sub> Value<br>(Ohms) | C <sub>L</sub> Value<br>(pF) |
|---------------------------------|--------------------------------|------------------------------|
| 10TTL                           | 390                            | 15                           |
| 5TTL                            | 780                            | 15                           |
| 2TTL                            | 1100                           | 6                            |
| 10LSTTL                         | 2000                           | 15                           |
| 1TTL                            | 2200                           | 3                            |







Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth

(>300MHz) passive probe is recommended.

Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.

Note 4: Resistance value R<sub>L</sub> is shown in Table 1. See applicable specification sheet for 'Load Drive Capability'.

Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



#### **Test Circuit for CMOS Output**



Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

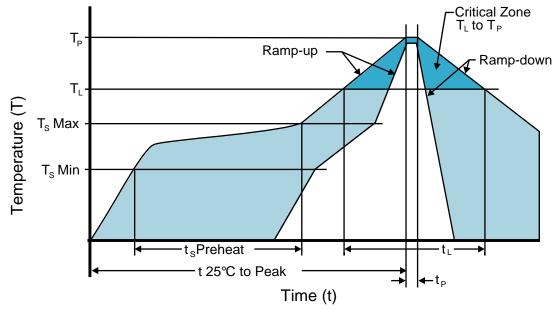
Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $\dot{C}_1$  includes sum of all probe and fixture capacitance.



## **Recommended Solder Reflow Methods**

EH2500ETTTS-44.237M



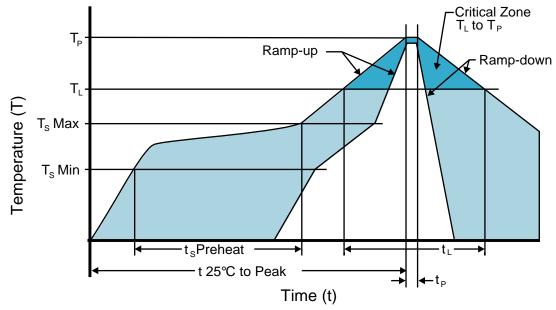
### **High Temperature Infrared/Convection**

| <b>. .</b>  |   |
|---|---|
| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)         | 3°C/second Maximum                                |
| Preheat   |   |
| - Temperature Minimum (T <sub>s</sub> MIN)                  | 150°C   |
| - Temperature Typical (T <sub>s</sub> TYP)                  | 175°C   |
| <ul> <li>Temperature Maximum (T<sub>s</sub> MAX)</li> </ul> | 200°C   |
| - Time (t <sub>s</sub> MIN)                                 | 60 - 180 Seconds                                  |
| Ramp-up Rate (T⊾ to T <sub>P</sub> )                        | 3°C/second Maximum                                |
| Time Maintained Above:                                      |   |
| - Temperature (T∟)  | 217°C   |
| - Time (t∟)   | 60 - 150 Seconds                                  |
| Peak Temperature (T <sub>P</sub> )                          | 260°C Maximum for 10 Seconds Maximum              |
| Target Peak Temperature (T <sub>P</sub> Target)             | 250°C +0/-5°C                                     |
| Time within 5°C of actual peak (t <sub>P</sub> )            | 20 - 40 seconds                                   |
| Ramp-down Rate  | 6°C/second Maximum                                |
| Time 25°C to Peak Temperature (t)                           | 8 minutes Maximum                                 |
| Moisture Sensitivity Level                                  | Level 1   |
| Additional Notes  | Temperatures shown are applied to body of device. |
|   |   |



### **Recommended Solder Reflow Methods**

EH2500ETTTS-44.237M



### Low Temperature Infrared/Convection 240°C

| $T_s$ MAX to $T_L$ (Ramp-up Rate)                | 5°C/second Maximum                                     |
|--|--|
| Preheat  |  |
| - Temperature Minimum (T <sub>s</sub> MIN)       | N/A  |
| - Temperature Typical (T <sub>s</sub> TYP)       | 150°C  |
| - Temperature Maximum (T <sub>s</sub> MAX)       | N/A  |
| - Time (t <sub>s</sub> MIN)                      | 60 - 120 Seconds                                       |
| Ramp-up Rate (T⊾ to T <sub>P</sub> )             | 5°C/second Maximum                                     |
| Time Maintained Above:                           |  |
| - Temperature (T∟)                               | 150°C  |
| - Time (t∟)                                      | 200 Seconds Maximum                                    |
| Peak Temperature (T <sub>P</sub> )               | 240°C Maximum  |
| Target Peak Temperature (T <sub>P</sub> Target)  | 240°C Maximum 1 Time / 230°C Maximum 2 Times           |
| Time within 5°C of actual peak (t <sub>p</sub> ) | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| Ramp-down Rate                                   | 5°C/second Maximum                                     |
| Time 25°C to Peak Temperature (t)                | N/A  |
| Moisture Sensitivity Level                       | Level 1  |
| Additional Notes                                 | Temperatures shown are applied to body of device.      |

#### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

### High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)